

Notice of References Cited

Application/Control No.

10/524,227

Applicant(s)/Patent Under
Reexamination
TANAKA ET AL.

Examiner

LINH T. NGUYEN

Art Unit

2627

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U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-2005/0025460	02-2005	Hyodo et al.	386/095
*	B	US-6,118,754	09-2000	Sako et al.	369/275.3
	C	US-			
	D	US-			
	E	US-			
	F	US-			
	G	US-			
	H	US-			
	I	US-			
	J	US-			
	K	US-			
	L	US-			
	M	US-			

FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	O					
	P					
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	T					

NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
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